# **Stress-Related Phenomena** in Electrochemical Systems 2

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## **Table of Contents**

Preface	iii
Stress and Microstructure in Electrodeposited Copper Nanofilms and the Effect of Chloride and Polyethylene Glycol (PEG)  M. O'Grady, C. Lenihan, D. N. Buckley	1
In Situ Measurement of Stress Evolution and Ion Dynamics in Conducting Polymers S. Sen, S. Kim, S. Jin, L. R. Palmore, N. Jadhav, E. Chason, G. T. R. Palmore	15
Author Index	23